

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/690,694	TAKAMIZAWA ET AL.	
Examiner	Art Unit	
Madeleine AV Nguyen	2626	

SEARCHED						
Class	Subclass	Date	Examiner			
update		1/21/2006	AV			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
East		6/21/2006	AV		
					